Search Notes

Application	n/Control N	lo.
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Applicant(s)/Patent under Reexamination

10/708,841

Examiner

BEENAU ET AL.

Nam V. Nguyen

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	SEARCHED				
Class	Subclass	Date	Examiner		
340	5.53	1/25/2006	NN		
340	5.2	1/25/2006	NN		
340	5.4+	1/25/2006	NN		
340	5.52	1/25/2006	NN		
340	5.6+	1/25/2006	NN		
340	5.7	1/25/2006	NN		
340	5.82	1/25/2006	NN		
340	10.1	1/25/2006	NN		
340	10.4-10.5	1/25/2006	NN		
340	439	1/25/2006	NN		
701	29	1/25/2006	NN		
235	379-380	1/25/2006	NN		
235	492	1/25/2006	NN		
705	35,54,76	1/25/2006	NN		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Search EAST: USPAT; US-PUB; EPO JPO, and Derwent	1/25/2006	NN		